

Notice of References Cited	Application/Control No. 10/673,636		Applicant(s)/Patent Under Reexamination VACON ET AL.	
	Examiner Khai M. Nguyen		Art Unit 2687	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,208,629 B1	03-2001	Jaszewski et al.	370/329
*	B	US-2002/0176437 A1	11-2002	Busch et al.	370/437
*	C	US-2003/0207699 A1	11-2003	Shpak, Eran	455/525
*	D	US-2004/0214572 A1	10-2004	Thompson et al.	455/435.2
*	E	US-2001/0010460	08-2001	Miller et al.	324/67
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.